

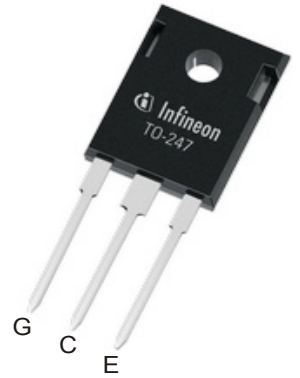
## High speed DuoPack: IGBT in Trench and Fieldstop technology with soft, fast recovery antiparallel diode

### Features

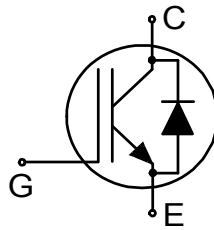
- $V_{CE} = 1200\text{ V}$
- $I_C = 40\text{ A}$
- Very low  $V_{CE,sat}$
- Low EMI
- Very soft, fast recovery antiparallel diode
- Maximum junction temperature  $T_{vjmax} = 175^\circ\text{C}$
- Qualified according to JEDEC for target applications
- Pb-free lead plating; RoHS compliant
- Complete product spectrum and PSpice Models: <http://www.infineon.com/igbt/>

### Potential applications

- Uninterruptible power supplies
- Welding converters
- Converters with high switching frequency



### Description



| Type        | Package    | Marking  |
|-------------|------------|----------|
| IKW40N120H3 | PG-TO247-3 | K40H1203 |

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## 1 Package

**Table 1** Characteristic values

| Parameter                                                      | Symbol        | Note or test condition                               | Values |      |      | Unit |
|----------------------------------------------------------------|---------------|------------------------------------------------------|--------|------|------|------|
|                                                                |               |                                                      | Min.   | Typ. | Max. |      |
| Internal emitter inductance measured 5 mm (0.197 in) from case | $L_E$         |                                                      |        | 13.0 |      | nH   |
| Storage temperature                                            | $T_{stg}$     |                                                      | -55    |      | 150  | °C   |
| Soldering temperature                                          |               | wave soldering 1.6 mm (0.063 in.) from case for 10 s |        |      | 260  | °C   |
| Mounting torque, M3 screw<br>Maximum of mounting processes: 3  | $M$           |                                                      |        |      | 0.6  | Nm   |
| Thermal resistance, junction-ambient                           | $R_{th(j-a)}$ |                                                      |        |      | 40   | K/W  |

## 2 IGBT

**Table 2** Maximum rated values

| Parameter                                              | Symbol      | Note or test condition                                                                                                                                                    | Values   | Unit          |
|--------------------------------------------------------|-------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------------|----------|---------------|
| Collector-emitter voltage                              | $V_{CE}$    |                                                                                                                                                                           | 1200     | V             |
| DC collector current, limited by $T_{vjmax}$           | $I_C$       | $T_c = 25\text{ °C}$                                                                                                                                                      | 80       | A             |
|                                                        |             | $T_c = 100\text{ °C}$                                                                                                                                                     | 40       |               |
| Pulsed collector current, $t_p$ limited by $T_{vjmax}$ | $I_{Cpuls}$ |                                                                                                                                                                           | 160      | A             |
| Turn-off safe operating area                           |             | $V_{CE} \leq 1200\text{ V}$ , $T_{vj} \leq 175\text{ °C}$                                                                                                                 | 160      | A             |
| Gate-emitter voltage                                   | $V_{GE}$    |                                                                                                                                                                           | $\pm 20$ | V             |
| Short circuit withstand time                           | $t_{SC}$    | $V_{CC} \leq 600\text{ V}$ , $V_{GE} = 15\text{ V}$ , Allowed number of short circuits < 1000, Time between short circuits $\geq 1.0\text{ s}$ , $T_{vj} = 175\text{ °C}$ | 10       | $\mu\text{s}$ |
| Power dissipation                                      | $P_{tot}$   | $T_c = 25\text{ °C}$                                                                                                                                                      | 483      | W             |
|                                                        |             | $T_c = 100\text{ °C}$                                                                                                                                                     | 220      |               |

**Table 3** Characteristic values

| Parameter                           | Symbol      | Note or test condition                        | Values |      |      | Unit |
|-------------------------------------|-------------|-----------------------------------------------|--------|------|------|------|
|                                     |             |                                               | Min.   | Typ. | Max. |      |
| Collector-emitter breakdown voltage | $V_{BRCES}$ | $I_C = 0.5\text{ mA}$ , $V_{GE} = 0\text{ V}$ | 1200   |      |      | V    |

Table 3 Characteristic values (continued)

| Parameter                            | Symbol        | Note or test condition                                                                                                                                                   | Values                                  |      |      | Unit |         |
|--------------------------------------|---------------|--------------------------------------------------------------------------------------------------------------------------------------------------------------------------|-----------------------------------------|------|------|------|---------|
|                                      |               |                                                                                                                                                                          | Min.                                    | Typ. | Max. |      |         |
| Collector-emitter saturation voltage | $V_{CE\ sat}$ | $I_C = 40.0\ A, V_{GE} = 15\ V$                                                                                                                                          | $T_{vj} = 25\ ^\circ C$                 |      | 2.05 | 2.40 | V       |
|                                      |               |                                                                                                                                                                          | $T_{vj} = 125\ ^\circ C$                |      | 2.50 |      |         |
|                                      |               |                                                                                                                                                                          | $T_{vj} = 175\ ^\circ C$                |      | 2.70 |      |         |
| Gate-emitter threshold voltage       | $V_{GEth}$    | $I_C = 1.00\ mA, V_{CE} = V_{GE}, T_{vj} = 175\ ^\circ C$                                                                                                                |                                         | 5.00 | 5.80 | 6.50 | V       |
| Zero gate voltage collector current  | $I_{CES}$     | $V_{CE} = 1200\ V, V_{GE} = 0\ V$                                                                                                                                        | $T_{vj} = 25\ ^\circ C$                 |      |      | 250  | $\mu A$ |
|                                      |               |                                                                                                                                                                          | $T_{vj} = 175\ ^\circ C$                |      |      | 2500 |         |
| Gate-emitter leakage current         | $I_{GES}$     | $V_{CE} = 0\ V, V_{GE} = 20\ V$                                                                                                                                          |                                         |      |      | 600  | nA      |
| Transconductance                     | $g_{fs}$      | $I_C = 40.0\ A, V_{CE} = 20\ V$                                                                                                                                          |                                         |      | 20.0 |      | S       |
| Short circuit collector current      | $I_{SC}$      | $V_{CC} \leq 600\ V, V_{GE} = 15\ V, t_{SC} \leq 10\ \mu s$ , Allowed number of short circuits < 1000, Time between short circuits $\geq 1.0\ s, T_{vj} = 175\ ^\circ C$ |                                         |      | 139  |      | A       |
| Input capacitance                    | $C_{ies}$     | $V_{CE} = 25\ V, V_{GE} = 0\ V, f = 1000\ kHz$                                                                                                                           |                                         |      | 2330 |      | pF      |
| Output capacitance                   | $C_{oes}$     | $V_{CE} = 25\ V, V_{GE} = 0\ V, f = 1000\ kHz$                                                                                                                           |                                         |      | 185  |      | pF      |
| Reverse transfer capacitance         | $C_{res}$     | $V_{CE} = 25\ V, V_{GE} = 0\ V, f = 1000\ kHz$                                                                                                                           |                                         |      | 130  |      | pF      |
| Gate charge                          | $Q_G$         | $I_C = 40.0\ A, V_{GE} = 15\ V, V_{CE} = 960\ V$                                                                                                                         |                                         |      | 185  |      | nC      |
| Turn-on delay time                   | $t_{don}$     | $V_{CE} = 600\ V, V_{GE} = 15\ V, R_{Gon} = 12.0\ \Omega, R_{Goff} = 12.0\ \Omega, L_\sigma = 70\ nH, C_\sigma = 67\ pF$                                                 | $T_{vj} = 25\ ^\circ C, I_C = 40.0\ A$  |      | 30   |      | ns      |
|                                      |               |                                                                                                                                                                          | $T_{vj} = 175\ ^\circ C, I_C = 40.0\ A$ |      | 29   |      |         |
| Rise time (inductive load)           | $t_r$         | $V_{CE} = 600\ V, V_{GE} = 15\ V, R_{Gon} = 12.0\ \Omega, R_{Goff} = 12.0\ \Omega, L_\sigma = 70\ nH, C_\sigma = 67\ pF$                                                 | $T_{vj} = 25\ ^\circ C, I_C = 40.0\ A$  |      | 57   |      | ns      |
|                                      |               |                                                                                                                                                                          | $T_{vj} = 175\ ^\circ C, I_C = 40.0\ A$ |      | 49   |      |         |
| Turn-off delay time                  | $t_{doff}$    | $V_{CE} = 600\ V, V_{GE} = 15\ V, R_{Gon} = 12.0\ \Omega, R_{Goff} = 12.0\ \Omega, L_\sigma = 70\ nH, C_\sigma = 67\ pF$                                                 | $T_{vj} = 25\ ^\circ C, I_C = 40.0\ A$  |      | 290  |      | ns      |
|                                      |               |                                                                                                                                                                          | $T_{vj} = 175\ ^\circ C, I_C = 40.0\ A$ |      | 366  |      |         |
| Fall time (inductive load)           | $t_f$         | $V_{CE} = 600\ V, V_{GE} = 15\ V, R_{Gon} = 12.0\ \Omega, R_{Goff} = 12.0\ \Omega, L_\sigma = 70\ nH, C_\sigma = 67\ pF$                                                 | $T_{vj} = 25\ ^\circ C, I_C = 40.0\ A$  |      | 16   |      | ns      |
|                                      |               |                                                                                                                                                                          | $T_{vj} = 175\ ^\circ C, I_C = 40.0\ A$ |      | 48   |      |         |
| Turn-on energy                       | $E_{on}$      | $V_{CE} = 600\ V, V_{GE} = 15\ V, R_{Gon} = 12.0\ \Omega, R_{Goff} = 12.0\ \Omega, L_\sigma = 70\ nH, C_\sigma = 67\ pF$                                                 | $T_{vj} = 25\ ^\circ C, I_C = 40.0\ A$  |      | 3.20 |      | mJ      |
|                                      |               |                                                                                                                                                                          | $T_{vj} = 175\ ^\circ C, I_C = 40.0\ A$ |      | 4.40 |      |         |

**Table 3** Characteristic values (continued)

| Parameter                              | Symbol     | Note or test condition                                                                                                                                              | Values                                                           |      |      | Unit |                    |
|----------------------------------------|------------|---------------------------------------------------------------------------------------------------------------------------------------------------------------------|------------------------------------------------------------------|------|------|------|--------------------|
|                                        |            |                                                                                                                                                                     | Min.                                                             | Typ. | Max. |      |                    |
| Turn-off energy                        | $E_{off}$  | $V_{CE} = 600\text{ V}, V_{GE} = 15\text{ V},$<br>$R_{Gon} = 12.0\ \Omega,$<br>$R_{Goff} = 12.0\ \Omega,$<br>$L_{\sigma} = 70\text{ nH}, C_{\sigma} = 67\text{ pF}$ | $T_{vj} = 25\text{ }^{\circ}\text{C},$<br>$I_C = 40.0\text{ A}$  |      | 1.20 |      | mJ                 |
|                                        |            |                                                                                                                                                                     | $T_{vj} = 175\text{ }^{\circ}\text{C},$<br>$I_C = 40.0\text{ A}$ |      | 2.60 |      |                    |
| Total switching energy                 | $E_{ts}$   | $V_{CE} = 600\text{ V}, V_{GE} = 15\text{ V},$<br>$R_{Gon} = 12.0\ \Omega,$<br>$R_{Goff} = 12.0\ \Omega,$<br>$L_{\sigma} = 70\text{ nH}, C_{\sigma} = 67\text{ pF}$ | $T_{vj} = 25\text{ }^{\circ}\text{C},$<br>$I_C = 40.0\text{ A}$  |      | 4.40 |      | mJ                 |
|                                        |            |                                                                                                                                                                     | $T_{vj} = 175\text{ }^{\circ}\text{C},$<br>$I_C = 40.0\text{ A}$ |      | 7.00 |      |                    |
| IGBT thermal resistance, junction-case | $R_{thjc}$ |                                                                                                                                                                     |                                                                  |      | 0.31 |      | K/W                |
| Operating junction temperature         | $T_{vj}$   |                                                                                                                                                                     | -40                                                              |      | 175  |      | $^{\circ}\text{C}$ |

Note: Electrical Characteristic, at  $T_{vj} = 25^{\circ}\text{C}$ , unless otherwise specified.

### 3 Diode

**Table 4** Maximum rated values

| Parameter                                     | Symbol      | Note or test condition                   | Values                              | Unit |   |
|-----------------------------------------------|-------------|------------------------------------------|-------------------------------------|------|---|
| Repetitive peak reverse voltage               | $V_{RRM}$   | $T_{vj} \geq 25\text{ }^{\circ}\text{C}$ | 1200                                | V    |   |
| Diode forward current, limited by $T_{vjmax}$ | $I_F$       |                                          | $T_c = 25\text{ }^{\circ}\text{C}$  | 40   | A |
|                                               |             |                                          | $T_c = 100\text{ }^{\circ}\text{C}$ | 20   |   |
| Diode pulsed current, limited by $T_{vjmax}$  | $I_{Fpuls}$ |                                          | 160                                 | A    |   |

**Table 5** Characteristic values

| Parameter               | Symbol | Note or test condition | Values                                 |      |      | Unit |               |
|-------------------------|--------|------------------------|----------------------------------------|------|------|------|---------------|
|                         |        |                        | Min.                                   | Typ. | Max. |      |               |
| Diode forward voltage   | $V_F$  | $I_F = 20.0\text{ A}$  | $T_{vj} = 25\text{ }^{\circ}\text{C}$  |      | 1.80 | 2.35 | V             |
|                         |        |                        | $T_{vj} = 175\text{ }^{\circ}\text{C}$ |      | 1.85 |      |               |
| Diode forward voltage   | $V_F$  | $I_F = 40.0\text{ A}$  | $T_{vj} = 25\text{ }^{\circ}\text{C}$  |      | 2.40 | 3.05 | V             |
|                         |        |                        | $T_{vj} = 125\text{ }^{\circ}\text{C}$ |      | 2.60 |      |               |
|                         |        |                        | $T_{vj} = 175\text{ }^{\circ}\text{C}$ |      | 2.60 |      |               |
| Reverse leakage current | $I_R$  | $V_R = 1200\text{ V}$  | $T_{vj} = 25\text{ }^{\circ}\text{C}$  |      |      | 250  | $\mu\text{A}$ |
|                         |        |                        | $T_{vj} = 175\text{ }^{\circ}\text{C}$ |      |      | 2500 |               |

**Table 5** Characteristic values (continued)

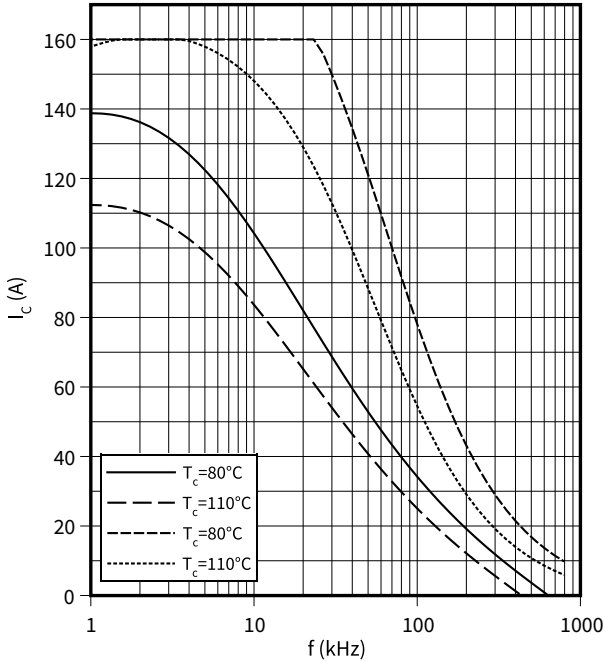
| Parameter                                            | Symbol       | Note or test condition |                                                                                             | Values |      |      | Unit                   |
|------------------------------------------------------|--------------|------------------------|---------------------------------------------------------------------------------------------|--------|------|------|------------------------|
|                                                      |              |                        |                                                                                             | Min.   | Typ. | Max. |                        |
| Diode reverse recovery time                          | $t_{rr}$     | $V_R = 600\text{ V}$   | $T_{vj} = 25\text{ °C},$<br>$I_F = 40.0\text{ A},$<br>$-di_F/dt = 500\text{ A}/\mu\text{s}$ |        | 355  |      | ns                     |
|                                                      |              |                        |                                                                                             |        | 639  |      |                        |
| Diode reverse recovery charge                        | $Q_{rr}$     | $V_R = 600\text{ V}$   | $T_{vj} = 25\text{ °C},$<br>$I_F = 40.0\text{ A},$<br>$-di_F/dt = 500\text{ A}/\mu\text{s}$ |        | 1.90 |      | $\mu\text{C}$          |
|                                                      |              |                        |                                                                                             |        | 4.30 |      |                        |
| Diode peak reverse recovery current                  | $I_{rrm}$    | $V_R = 600\text{ V}$   | $T_{vj} = 25\text{ °C},$<br>$I_F = 40.0\text{ A},$<br>$-di_F/dt = 500\text{ A}/\mu\text{s}$ |        | 12.8 |      | A                      |
|                                                      |              |                        |                                                                                             |        | 16.0 |      |                        |
| Diode peak rate off fall of reverse recovery current | $di_{rr}/dt$ | $V_R = 600\text{ V}$   | $T_{vj} = 25\text{ °C},$<br>$I_F = 40.0\text{ A},$<br>$-di_F/dt = 500\text{ A}/\mu\text{s}$ |        | -105 |      | $\text{A}/\mu\text{s}$ |
|                                                      |              |                        |                                                                                             |        | -84  |      |                        |
| Diode thermal resistance, junction-case              | $R_{thjc}$   |                        |                                                                                             |        |      | 1.11 | K/W                    |
| Operating junction temperature                       | $T_{vj}$     |                        |                                                                                             | -40    |      | 175  | $^{\circ}\text{C}$     |

## 4 Characteristics diagrams

### Collector current as a function of switching frequency, IGBT

$$I_C = f(f)$$

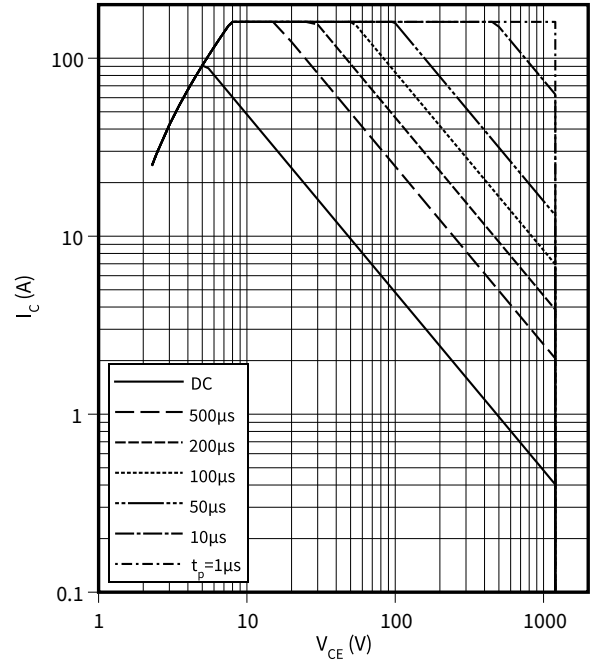
$D = 0.5, V_{CE} = 600 \text{ V}, T_{vj} \leq 175 \text{ }^\circ\text{C}, V_{GE} = 0/15 \text{ V}, R_G = 12 \text{ } \Omega$



### Forward bias safe operating area, IGBT

$$I_C = f(V_{CE})$$

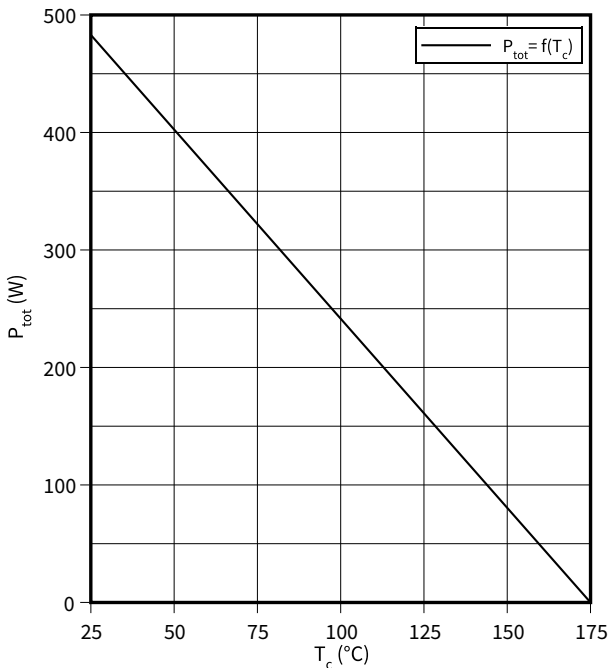
$D = 0, T_{vj} \leq 175 \text{ }^\circ\text{C}, V_{GE} = 15 \text{ V}, T_c = 25 \text{ }^\circ\text{C}$



### Power dissipation as a function of case temperature, IGBT

$$P_{tot} = f(T_c)$$

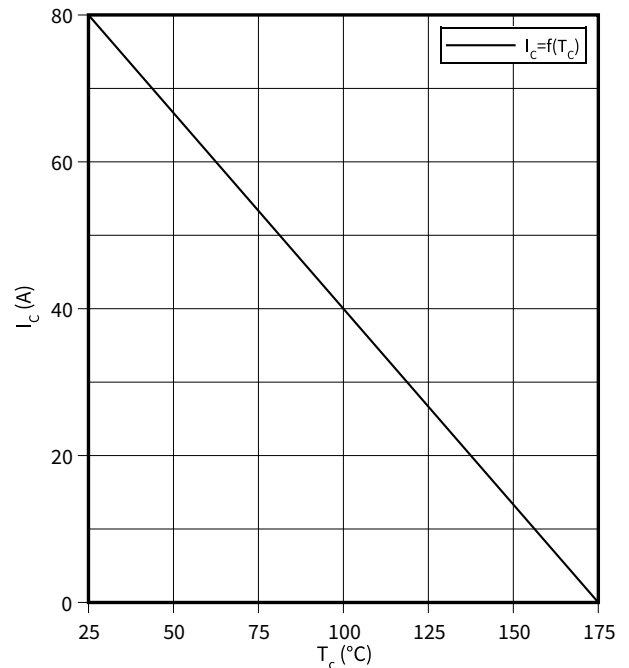
$T_{vj} \leq 175 \text{ }^\circ\text{C}$



### Collector current as a function of case temperature, IGBT

$$I_C = f(T_c)$$

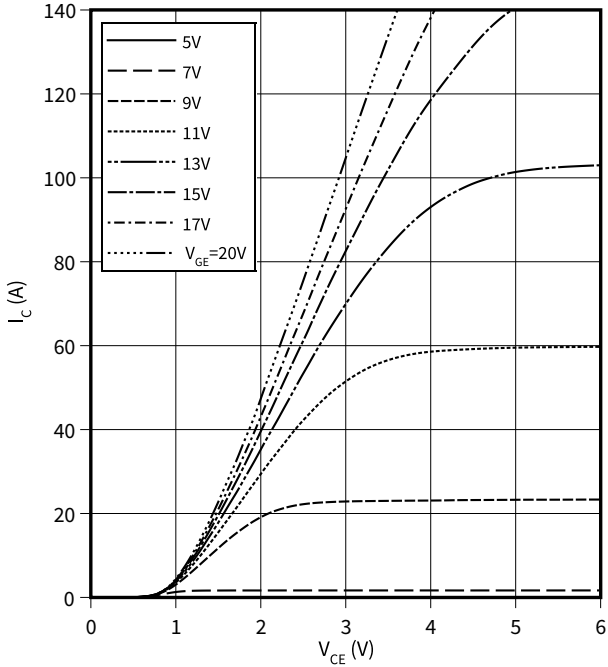
$T_{vj} \leq 175 \text{ }^\circ\text{C}, V_{GE} \geq 15 \text{ V}$



4 Characteristics diagrams

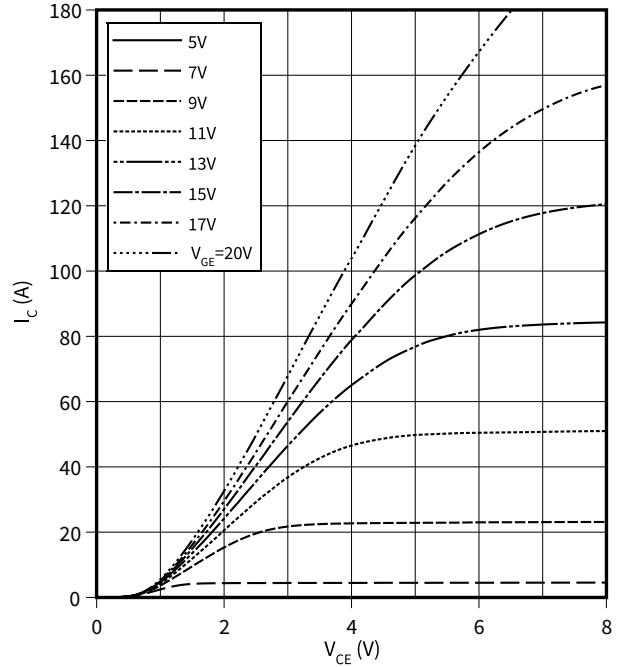
**Typical output characteristic, IGBT**

$I_C = f(V_{CE})$   
 $T_{vj} = 25\text{ °C}$



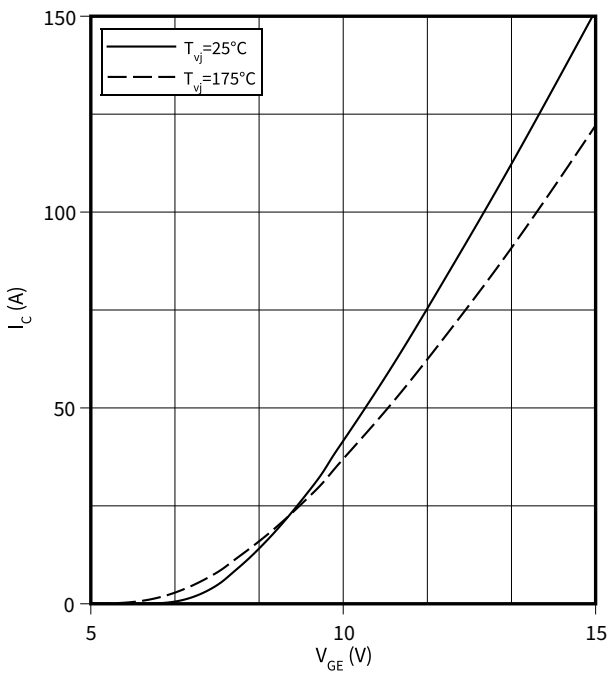
**Typical output characteristic, IGBT**

$I_C = f(V_{CE})$   
 $T_{vj} = 175\text{ °C}$



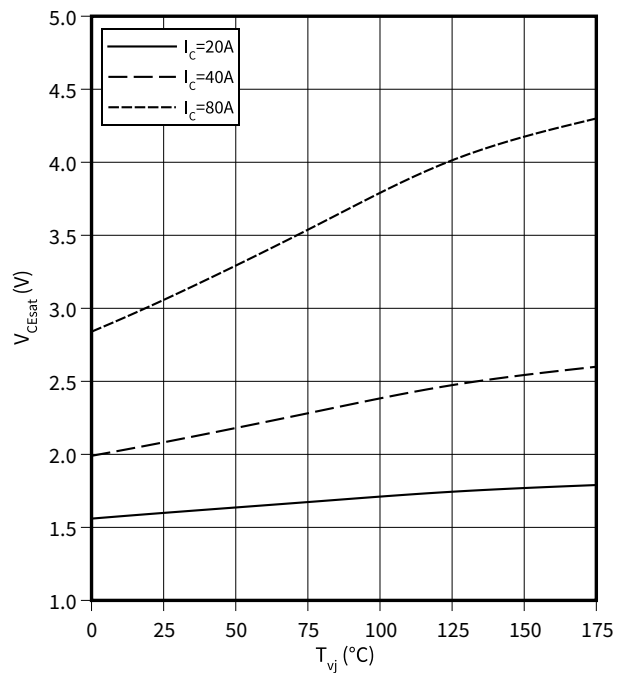
**Typical transfer characteristic, IGBT**

$I_C = f(V_{GE})$   
 $V_{CE} = 20\text{ V}$



**Typical collector-emitter saturation voltage as a function of junction temperature, IGBT**

$V_{CEsat} = f(T_{vj})$   
 $V_{GE} = 15\text{ V}$

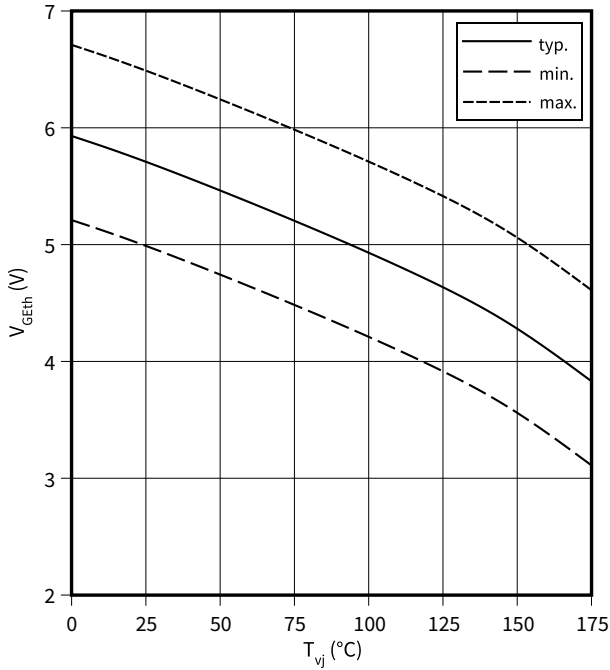




4 Characteristics diagrams

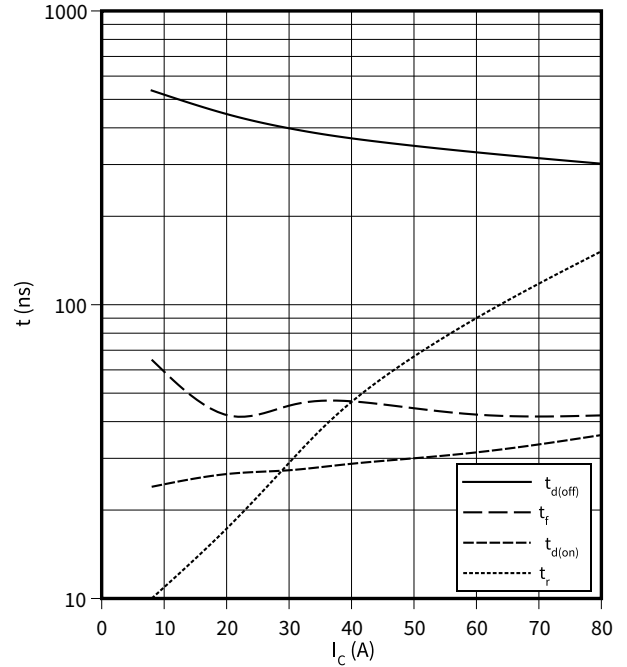
**Gate-emitter threshold voltage as a function of junction temperature, IGBT**

$V_{GEth} = f(T_{vj})$   
 $I_C = 1.00 \text{ mA}$



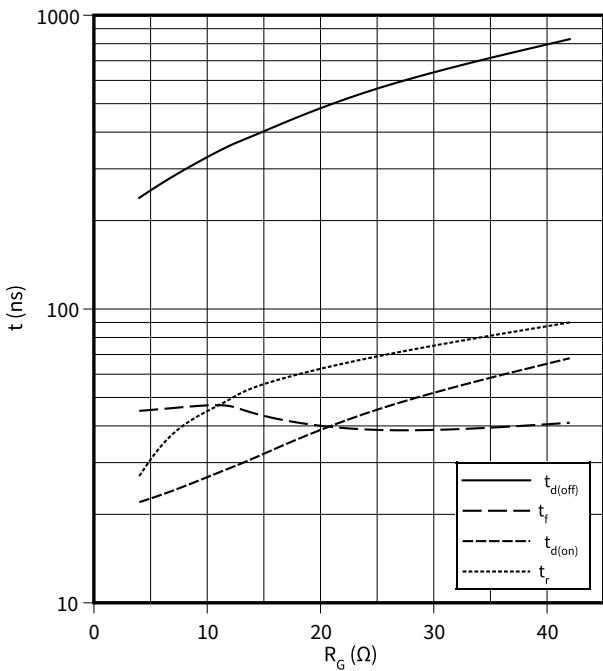
**Typical switching times as a function of collector current, IGBT**

$t = f(I_C)$   
 $V_{CE} = 600 \text{ V}, T_{vj} = 175 \text{ °C}, V_{GE} = 0/15 \text{ V}, R_G = 12 \text{ } \Omega$



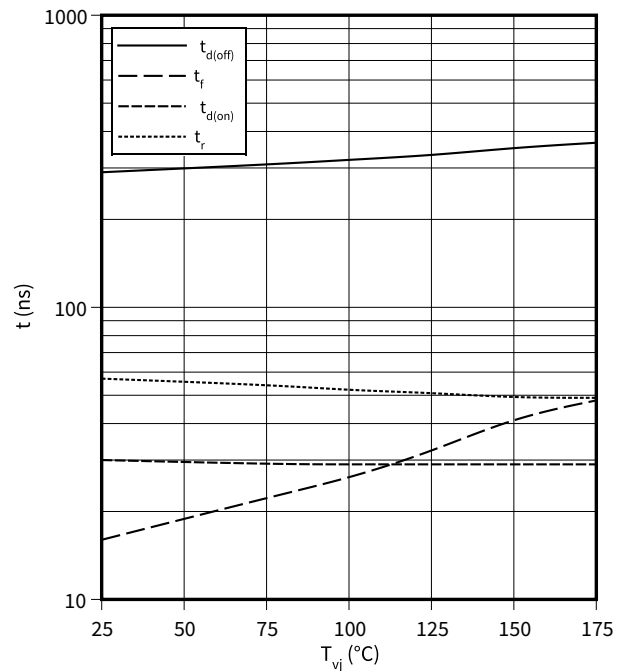
**Typical switching times as a function of gate resistance, IGBT**

$t = f(R_G)$   
 $I_C = 40.0 \text{ A}, V_{CE} = 600 \text{ V}, T_{vj} = 175 \text{ °C}, V_{GE} = 0/15 \text{ V}$



**Typical switching times as a function of junction temperature, IGBT**

$t = f(T_{vj})$   
 $I_C = 40.0 \text{ A}, V_{CE} = 600 \text{ V}, V_{GE} = 0/15 \text{ V}, R_G = 12 \text{ } \Omega$

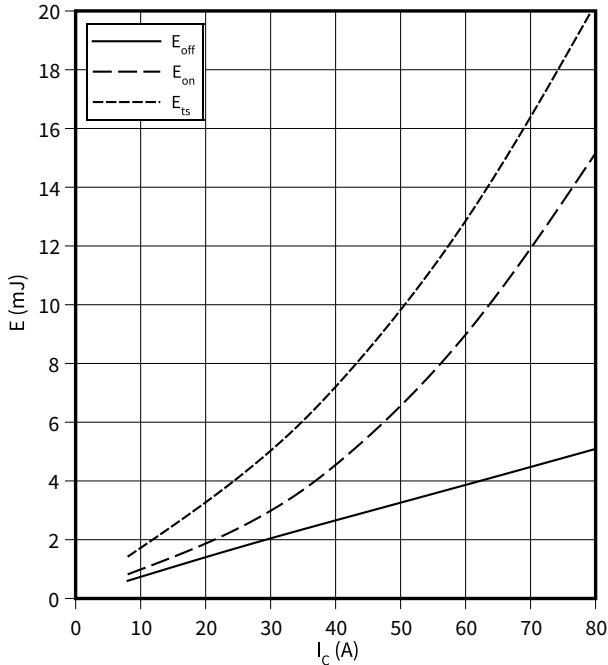


4 Characteristics diagrams

**Typical switching energy losses as a function of collector current, IGBT**

$E = f(I_C)$

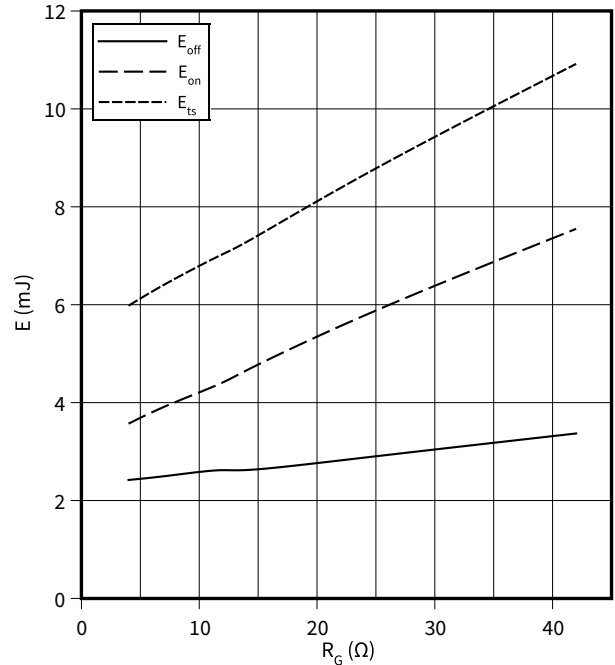
$V_{CE} = 600 \text{ V}, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GE} = 0/15 \text{ V}, R_G = 12 \text{ } \Omega$



**Typical switching energy losses as a function of gate resistance, IGBT**

$E = f(R_G)$

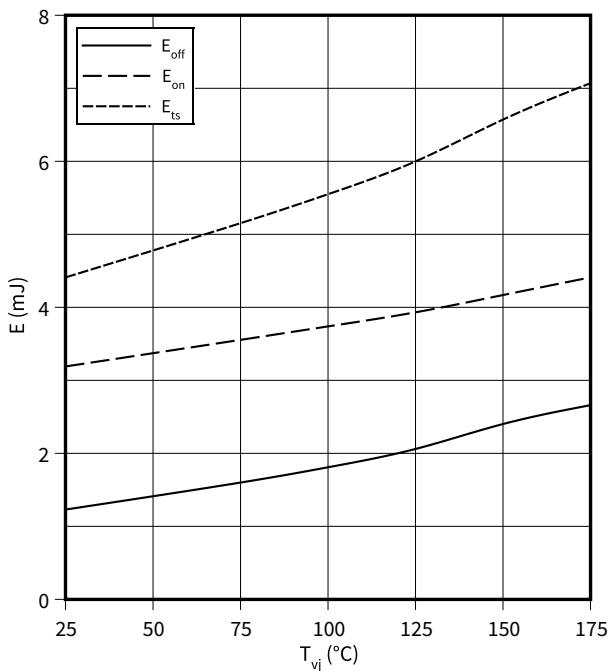
$I_C = 40.0 \text{ A}, V_{CE} = 600 \text{ V}, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GE} = 0/15 \text{ V}$



**Typical switching energy losses as a function of junction temperature, IGBT**

$E = f(T_{vj})$

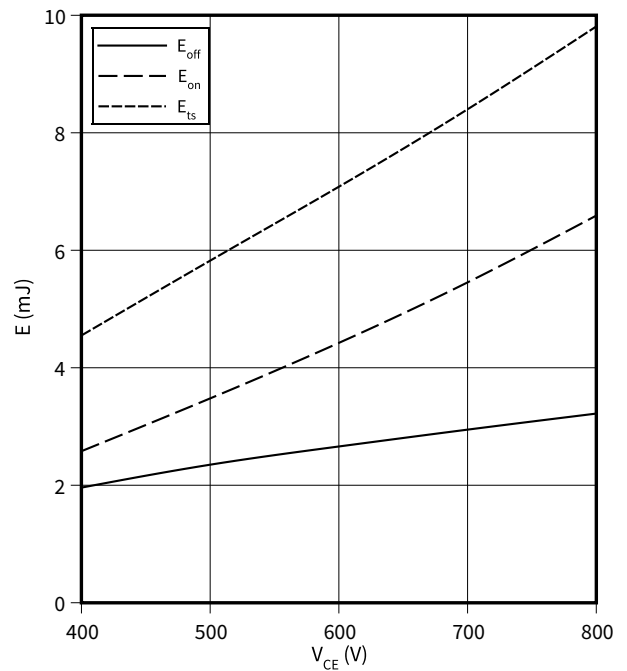
$I_C = 40.0 \text{ A}, V_{CE} = 600 \text{ V}, V_{GE} = 0/15 \text{ V}, R_G = 12 \text{ } \Omega$



**Typical switching energy losses as a function of collector emitter voltage, IGBT**

$E = f(V_{CE})$

$I_C = 40.0 \text{ A}, T_{vj} = 175 \text{ }^\circ\text{C}, V_{GE} = 0/15 \text{ V}, R_G = 12 \text{ } \Omega$

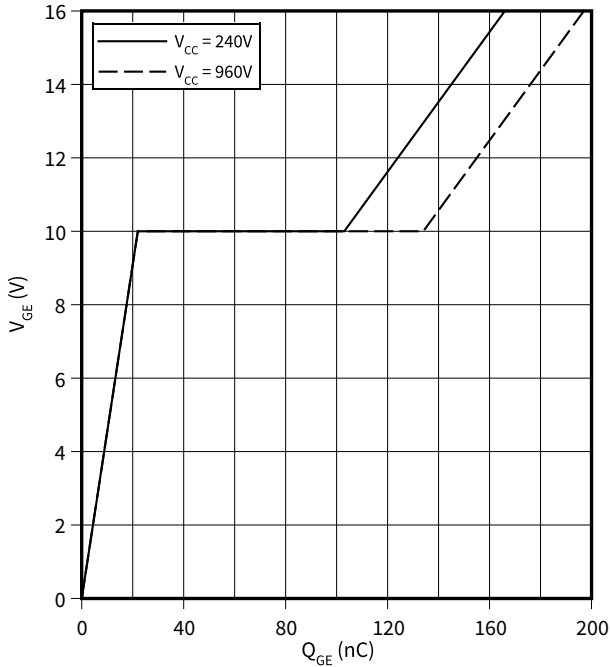


**4 Characteristics diagrams**

**Typical gate charge, IGBT**

$V_{GE} = f(Q_{GE})$

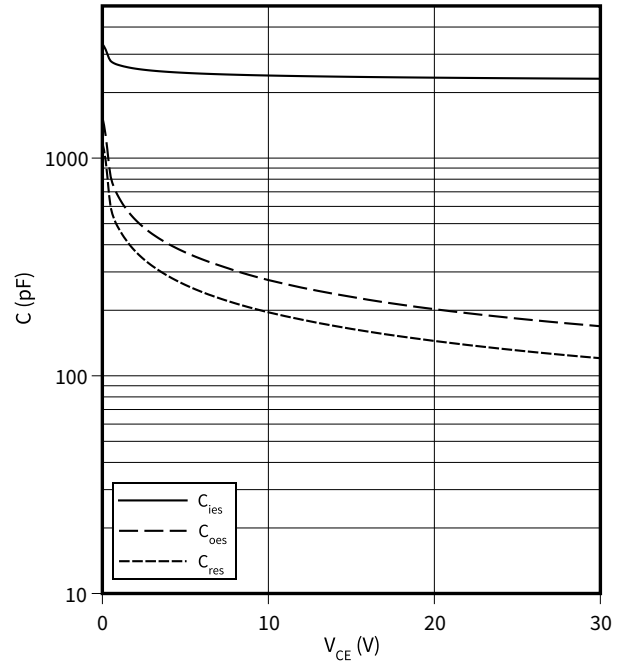
$I_C = 40.0 \text{ A}$



**Typical capacitance as a function of collector-emitter voltage, IGBT**

$C = f(V_{CE})$

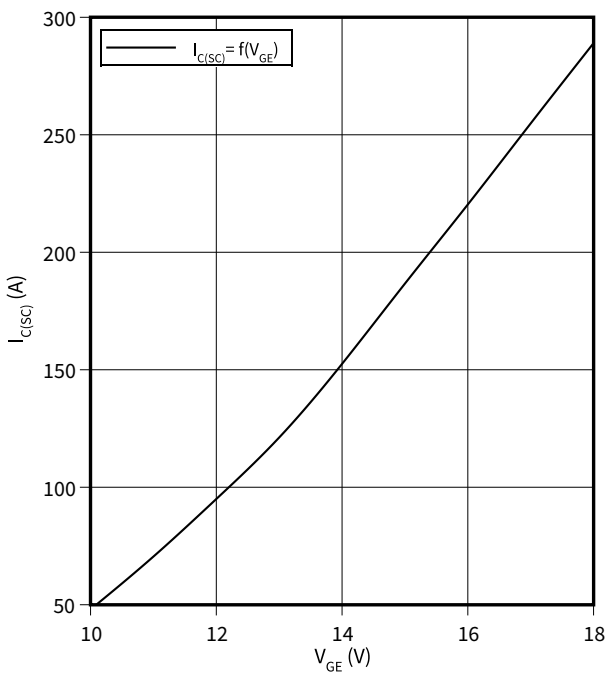
$f = 1000 \text{ kHz}, V_{GE} = 0 \text{ V}$



**Typical short circuit collector current as a function of gate-emitter voltage, IGBT**

$I_{C(SC)} = f(V_{GE})$

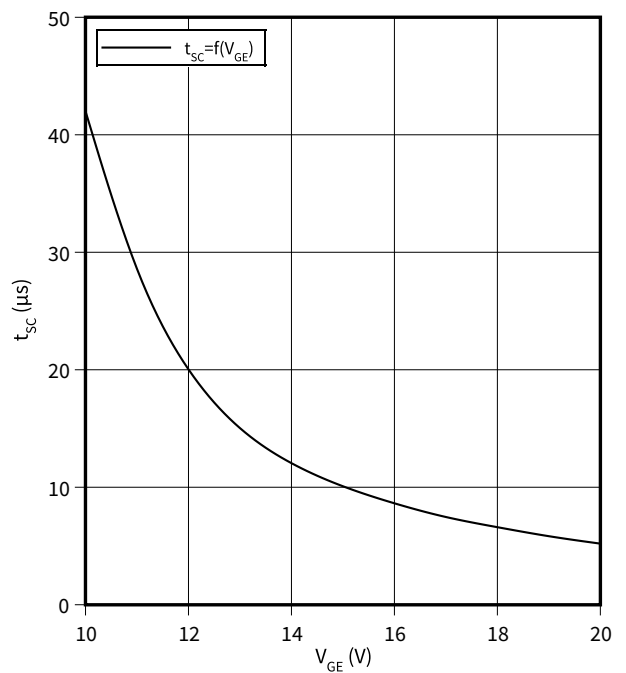
$V_{CE} \leq 600 \text{ V}, T_{vj, start} = 25 \text{ }^\circ\text{C}$



**Short circuit withstand time as a function of gate-emitter voltage, IGBT**

$t_{SC} = f(V_{GE})$

$T_{vj} \leq 175 \text{ }^\circ\text{C}, V_{CC} \leq 600 \text{ V}$

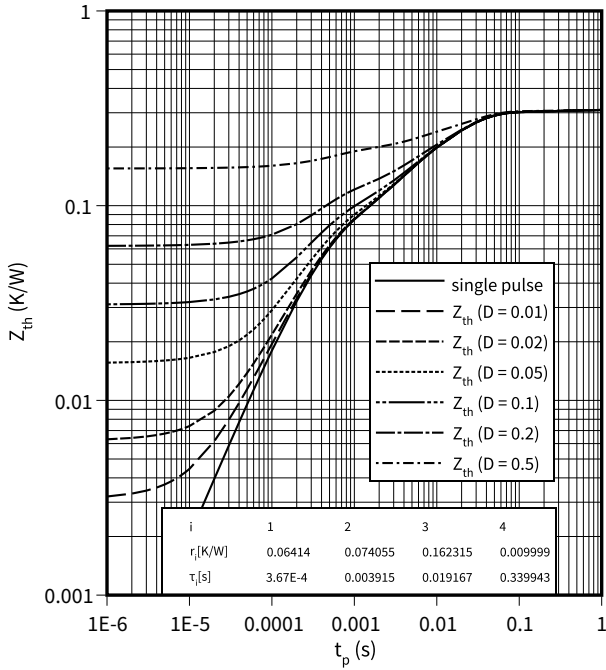


**4 Characteristics diagrams**

**IGBT transient thermal impedance, IGBT**

$Z_{th} = f(t_p)$

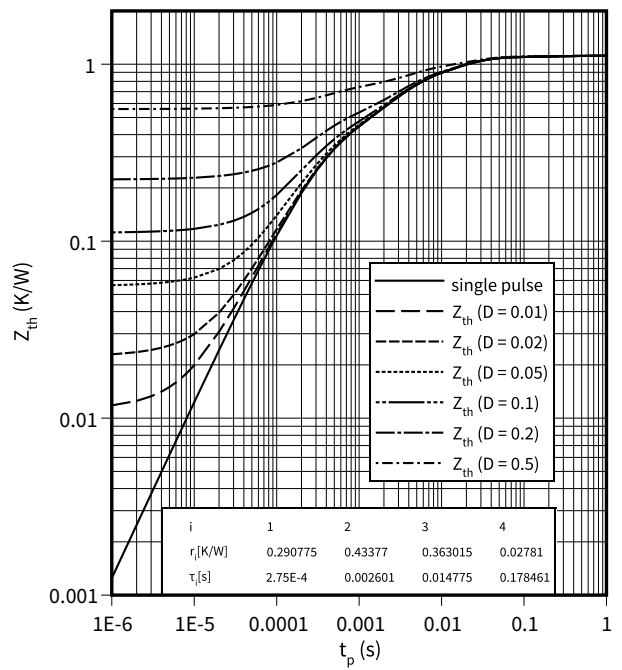
$D = t_p/T$



**Diode transient thermal impedance as a function of pulse width, Diode**

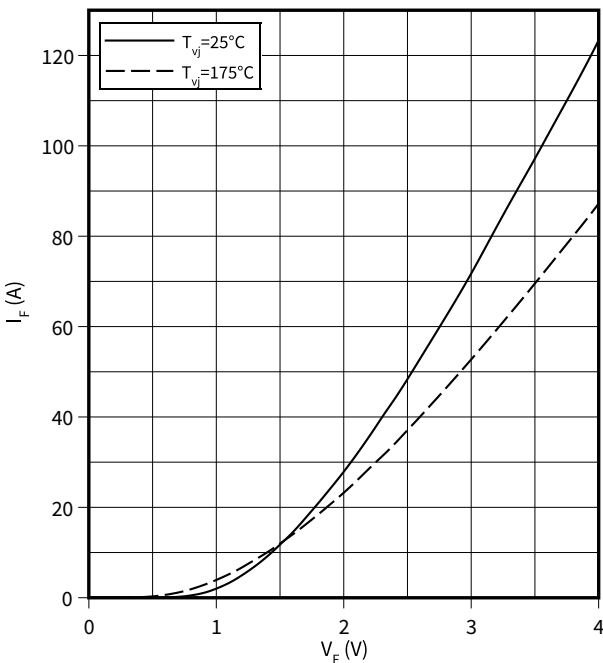
$Z_{th} = f(t_p)$

$D = t_p/T$



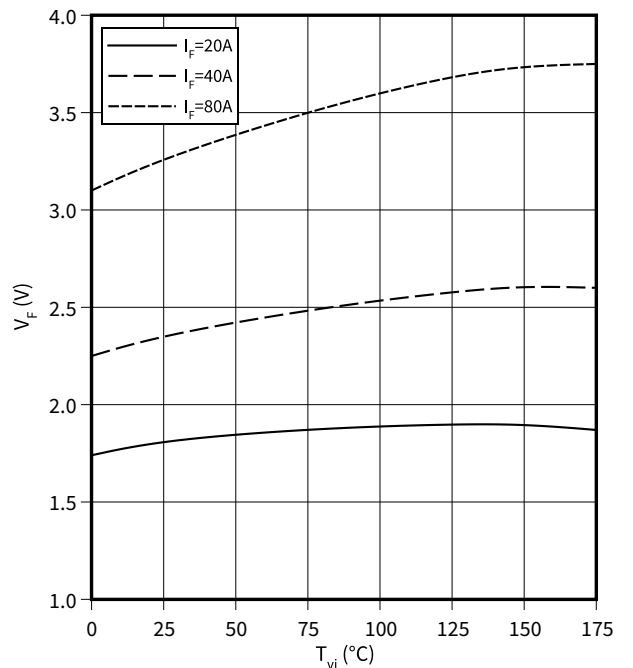
**Typical diode forward current as a function of forward voltage, Diode**

$I_F = f(V_F)$



**Typical diode forward voltage as a function of junction temperature, Diode**

$V_F = f(T_{vj})$

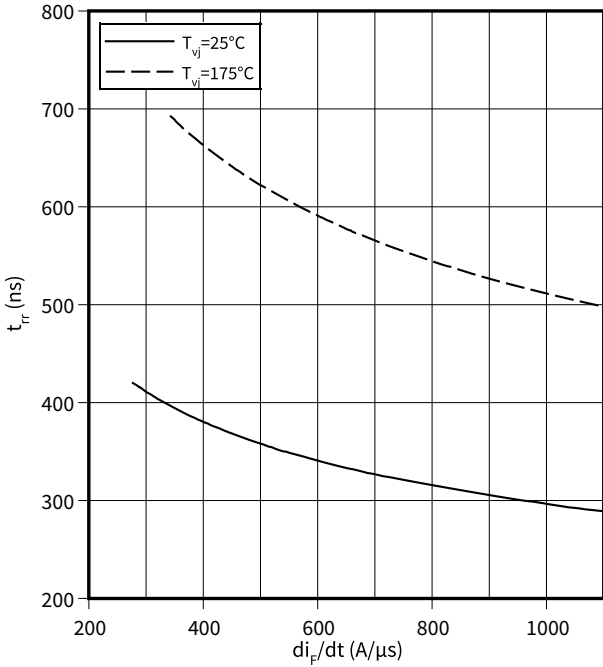


4 Characteristics diagrams

**Typical reverse recovery time as a function of diode current slope, Diode**

$t_{rr} = f(di_F/dt)$

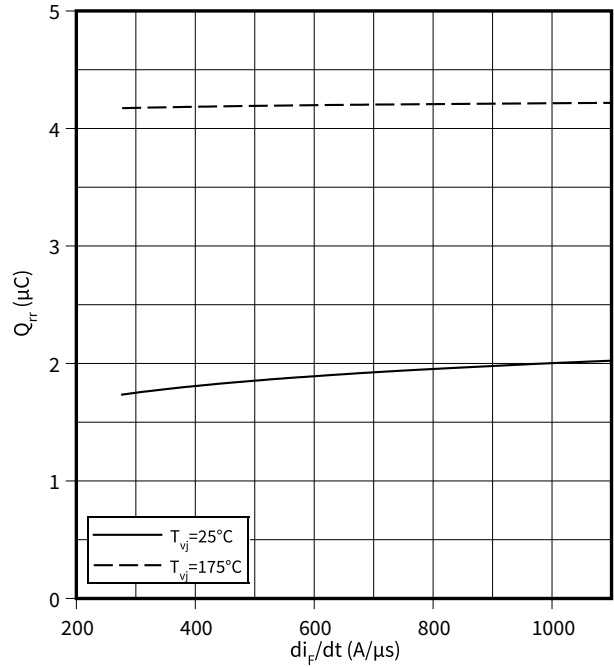
$V_R = 600\text{ V}, I_F = 40\text{ A}$



**Typical reverse recovery charge as a function of diode current slope, Diode**

$Q_{rr} = f(di_F/dt)$

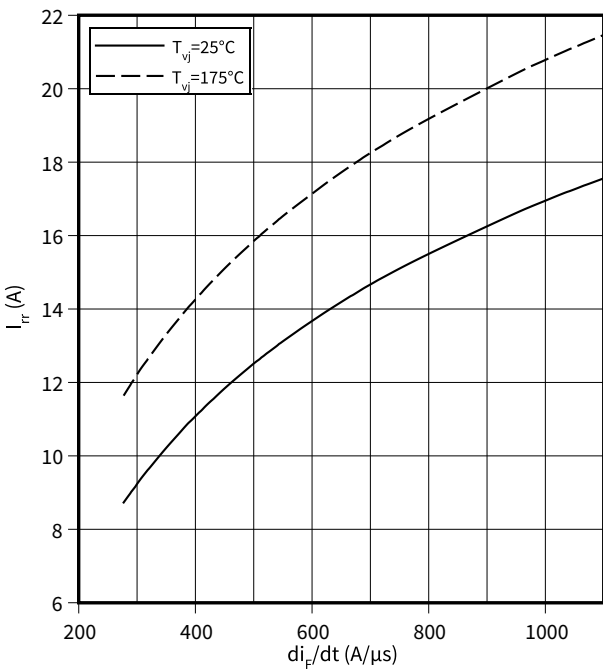
$V_R = 600\text{ V}, I_F = 40\text{ A}$



**Typical reverse recovery current as a function of diode current slope, Diode**

$I_{rr} = f(di_F/dt)$

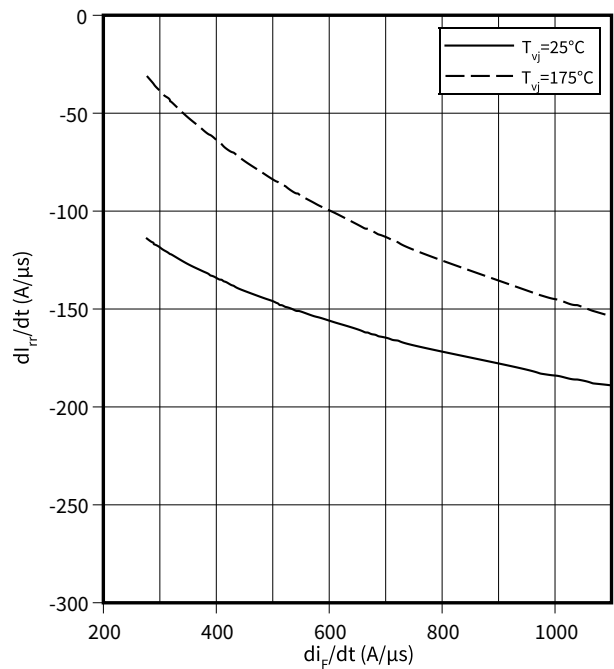
$V_R = 600\text{ V}, I_F = 40\text{ A}$



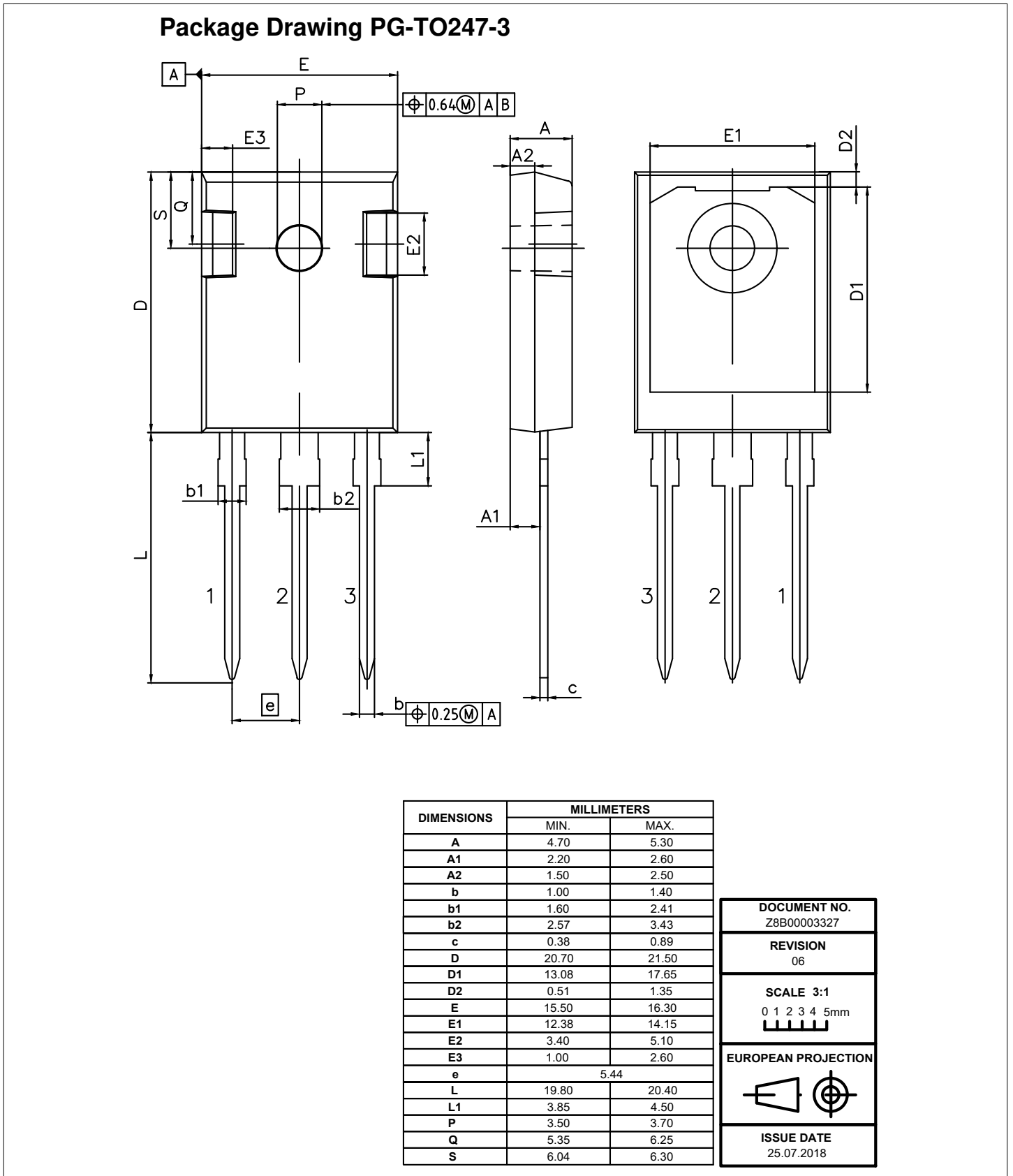
**Typical diode peak rate of fall of reverse recovery current as a function of diode current slope, Diode**

$dI_{rr}/dt = f(di_F/dt)$

$V_R = 600\text{ V}, I_F = 40\text{ A}$

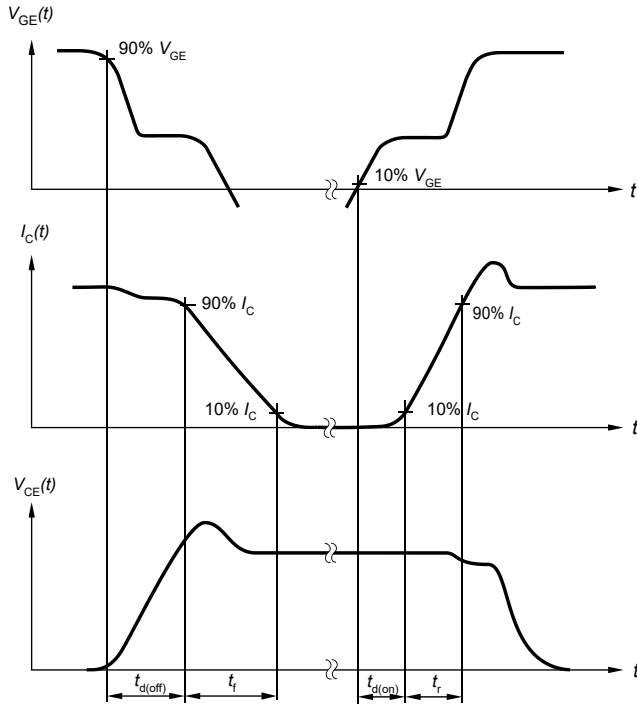


**5 Package outlines**

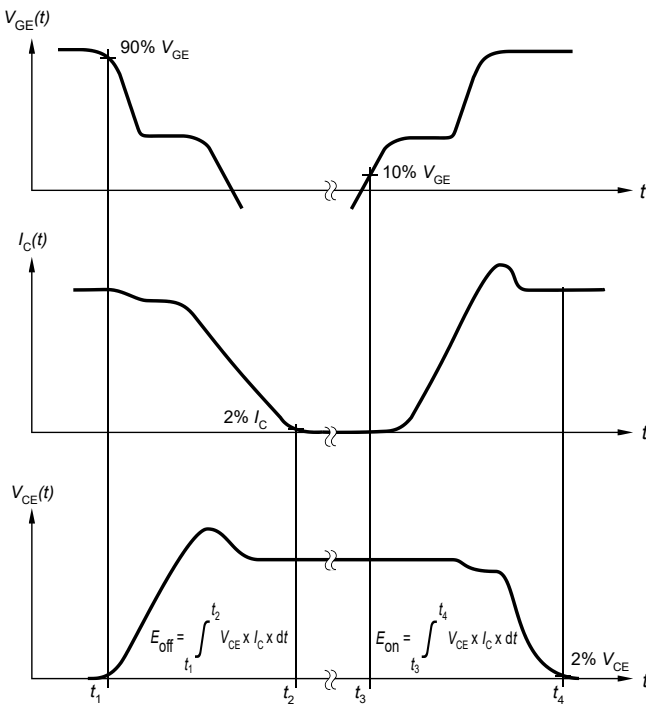


**Figure 6**

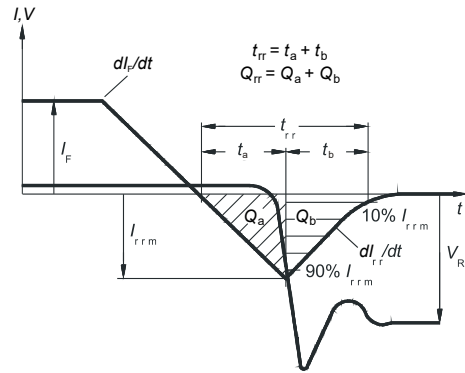
**6 Testing conditions**



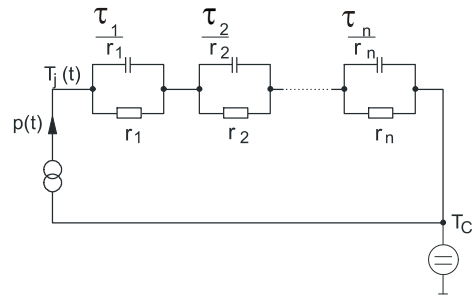
**Figure A. Definition of switching times**



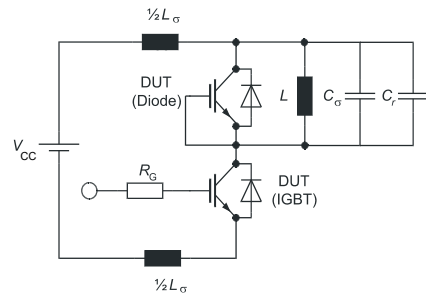
**Figure B. Definition of switching losses**



**Figure C. Definition of diode switching characteristics**



**Figure D. Thermal equivalent circuit**



**Figure E. Dynamic test circuit**  
 Parasitic inductance  $L_\sigma$ ,  
 parasitic capacitor  $C_\sigma$ ,  
 relief capacitor  $C_r$ ,  
 (only for ZVT switching)

**Figure 7**

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**Revision history****Revision history**

| <b>Document revision</b> | <b>Date of release</b> | <b>Description of changes</b>                     |
|--------------------------|------------------------|---------------------------------------------------|
| V1.1                     | 2009-12-03             |                                                   |
| V1.2                     | 2010-02-10             |                                                   |
| V2.1                     | 2014-11-26             | Final data sheet                                  |
| V2.2                     |                        | Minor change figure 28                            |
| 1.10                     | 2021-09-08             | Update of legend at the diagram $V_F = f(T_{vj})$ |